	Application/Control No.	Applicant(s)/Patent Under Reexamination
Issue Classification	09100624	PHAN, DEAN VAN
	Examiner	Art Unit
	Befumo, Jenna-Leigh	1771

		ORIGINAL	NAL						INTERNATIONAL CLASSIFICATION	CLASSIFICATION	
	CLASS			SUBCLASS					CLAIMED	NON-CI	NON-CLAIMED
442			270			В	3	2 E	B 5/26		
	) · :	CROSS PEFEBENCE(S)	DENCE(S)			В	3	2 E	B 5/06		
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442	203	239	240	255	277						
428	172	196									
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				JENNA BEFUMO			7,		1/20-	Total Claims Allowed:	is Allowed:
(Assistant Examiner)	hiner)	(Date)	<b>d</b>	PRIMARY EXAMINER	<i>'</i>	Jen o	3				21
	May 11		7 Jenna-L€	Jenna-Leigh Befumo			1/,	1/3/07		O.G. Print Claim(s)	O.G. Print Figure
(Legal Instruments Examiner)		$(D_{aff})^{\circ}$	(Primary	(Primary Examiner)			9	(Date)		-	-

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